



# POWER-MOS FET

## FIELD EFFECT POWER TRANSISTOR

**IRF742,743**

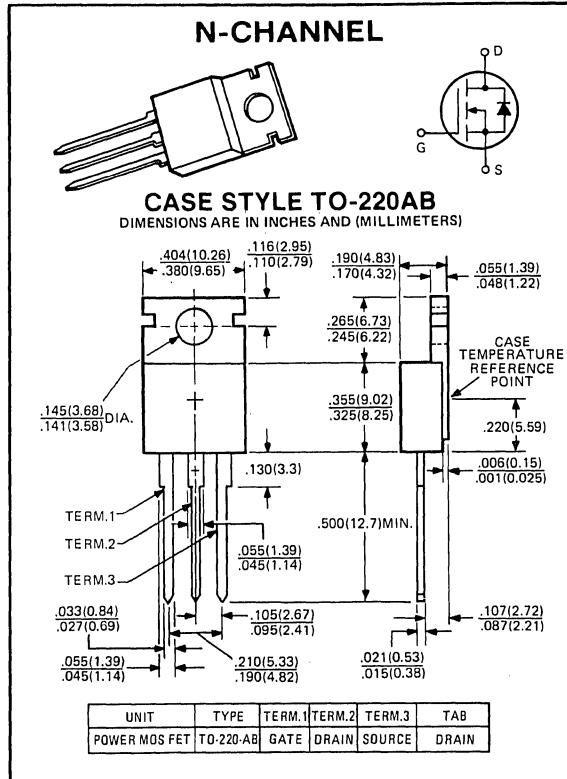
8 AMPERES  
400, 350 VOLTS  
 $R_{DS(ON)} = 0.80 \Omega$

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

### Features

- Polysilicon gate — Improved stability and reliability
- No secondary breakdown — Excellent ruggedness
- Ultra-fast switching — Independent of temperature
- Voltage controlled — High transconductance
- Low input capacitance — Reduced drive requirement
- Excellent thermal stability — Ease of paralleling



maximum ratings ( $T_C = 25^\circ C$ ) (unless otherwise specified)

| RATING  | SYMBOL         | IRF742     | IRF743     | UNITS                 |
|---|----------------|------------|------------|-----------------------|
| Drain-Source Voltage  | $V_{DSS}$      | 400        | 350        | Volts                 |
| Drain-Gate Voltage, $R_{GS} = 1M\Omega$                                   | $V_{DGR}$      | 400        | 350        | Volts                 |
| Continuous Drain Current @ $T_C = 25^\circ C$<br>@ $T_C = 100^\circ C$    | $I_D$          | 8<br>5     | 8<br>5     | A<br>A                |
| Pulsed Drain Current <sup>(1)</sup>                                       | $I_{DM}$       | 32         | 32         | A                     |
| Gate-Source Voltage   | $V_{GS}$       | $\pm 20$   | $\pm 20$   | Volts                 |
| Total Power Dissipation @ $T_C = 25^\circ C$<br>Derate Above $25^\circ C$ | $P_D$          | 125<br>1.0 | 125<br>1.0 | Watts<br>$W/^\circ C$ |
| Operating and Storage<br>Junction Temperature Range                       | $T_J, T_{STG}$ | -55 to 150 | -55 to 150 | $^\circ C$            |

### thermal characteristics

|   |                 |      |      |              |
|---|-----------------|------|------|--------------|
| Thermal Resistance, Junction to Case  | $R_{\theta JC}$ | 1.00 | 1.00 | $^\circ C/W$ |
| Thermal Resistance, Junction to Ambient   | $R_{\theta JA}$ | 80   | 80   | $^\circ C/W$ |
| Maximum Lead Temperature for Soldering<br>Purposes: $1/8''$ from Case for 5 Seconds | $T_L$           | 260  | 260  | $^\circ C$   |

(1) Repetitive Rating: Pulse width limited by max. junction temperature.

# electrical characteristics ( $T_C = 25^\circ C$ ) (unless otherwise specified)

| CHARACTERISTIC  | SYMBOL           | MIN        | TYP        | MAX         | UNIT    |
|---|------------------|------------|------------|-------------|---------|
| <b>off characteristics</b>  |                  |            |            |             |         |
| Drain-Source Breakdown Voltage<br>( $V_{GS} = 0V$ , $I_D = 250 \mu A$ )   | IRF742<br>IRF743 | $BV_{DSS}$ | 400<br>350 | —           | Volts   |
| Zero Gate Voltage Drain Current<br>( $V_{DS} = \text{Max Rating}$ , $V_{GS} = 0V$ , $T_C = 25^\circ C$ )<br>( $V_{DS} = \text{Max Rating} \times 0.8$ , $V_{GS} = 0V$ , $T_C = 125^\circ C$ ) | $I_{DSS}$        | —<br>—     | —<br>—     | 250<br>1000 | $\mu A$ |
| Gate-Source Leakage Current<br>( $V_{GS} = \pm 20V$ )   | $I_{GSS}$        | —          | —          | $\pm 500$   | nA      |

## on characteristics\*

|  |                    |              |     |      |      |       |
|--|--------------------|--------------|-----|------|------|-------|
| Gate Threshold Voltage<br>( $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$ )        | $T_C = 25^\circ C$ | $V_{GS(TH)}$ | 2.0 | —    | 4.0  | Volts |
| On-State Drain Current<br>( $V_{GS} = 10V$ , $V_{DS} = 10V$ )              |                    | $I_{D(ON)}$  | 8   | —    | —    | A     |
| Static Drain-Source On-State Resistance<br>( $V_{GS} = 10V$ , $I_D = 5A$ ) |                    | $R_{DS(ON)}$ | —   | 0.70 | 0.80 | Ohms  |
| Forward Transconductance<br>( $V_{DS} = 10V$ , $I_D = 5A$ )                |                    | $g_{fs}$     | 3.2 | 4.5  | —    | mhos  |

## dynamic characteristics

|                              |  |           |   |      |      |    |
|------------------------------|--|-----------|---|------|------|----|
| Input Capacitance            | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1 MHz$ | $C_{iss}$ | — | 1400 | 1600 | pF |
| Output Capacitance           |  | $C_{oss}$ | — | 210  | 450  | pF |
| Reverse Transfer Capacitance |  | $C_{rss}$ | — | 37   | 150  | pF |

## switching characteristics\*

|                     |   |              |   |    |   |    |
|---------------------|---|--------------|---|----|---|----|
| Turn-on Delay Time  | $V_{DS} = 175V$<br>$I_D = 5A$ , $V_{GS} = 15V$<br>$R_{GEN} = 50\Omega$ , $R_{GS} = 12.5\Omega$<br>( $R_{GS}$ EQUIV.) = $10\Omega$ ) | $t_{d(on)}$  | — | 20 | — | ns |
| Rise Time           |   | $t_r$        | — | 20 | — | ns |
| Turn-off Delay Time |   | $t_{d(off)}$ | — | 70 | — | ns |
| Fall Time           |   | $t_f$        | — | 30 | — | ns |

## source-drain diode ratings and characteristics\*

|   |                      |   |            |     |               |
|---|----------------------|---|------------|-----|---------------|
| Continuous Source Current   | $I_S$                | — | —          | 8   | A             |
| Pulsed Source Current   | $I_{SM}$             | — | —          | 32  | A             |
| Diode Forward Voltage<br>( $T_C = 25^\circ C$ , $V_{GS} = 0V$ , $I_S = 8A$ )              | $V_{SD}$             | — | 0.8        | 1.9 | Volts         |
| Reverse Recovery Time<br>( $I_S = 10A$ , $dI_S/dt = 100A/\mu sec$ , $T_C = 125^\circ C$ ) | $t_{rr}$<br>$Q_{RR}$ | — | 420<br>5.5 | —   | ns<br>$\mu C$ |

\*Pulse Test: Pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$

